



IEEE Standard for Test Methods for the Characterization of Organic Transistors and Materials

IEEE Computer Society

Sponsored by the
Microprocessor Standards Committee

1620TM

IEEE
3 Park Avenue
New York, NY 10016-5997, USA
5 December 2008

IEEE Std 1620TM-2008
(Revision of
IEEE Std 1620-2004)

This is a preview. [Click here to purchase the full publication.](#)

This is a preview. [Click here to purchase the full publication.](#)

IEEE Standard for Test Methods for the Characterization of Organic Transistors and Materials

Sponsor
Microprocessor Standards Committee
of the
IEEE Computer Society

Approved 26 September 2008
IEEE-SA Standards Board